

Notice of References Cited	Application/Control No. 10/776,791	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
	Examiner John L. Goodrow	Art Unit 1756	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,677,097	01-2004	Ohmura et al.	430/110.3
*	B	US-6,475,685	11-2002	Uchida et al.	430/99
*	C	US-6,395,442	05-2002	Hayashi et al.	430/109.4
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	EP 1 385 062	01-2004	European	Matsumura et al	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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